


Search Notes 	Application/Control No. 10663516	Applicant(s)/Patent Under Reexamination CRINON ET AL.
	Examiner JUNIOR O MENDOZA	Art Unit 4115

SEARCHED			
Class	Subclass	Date	Examiner
725	37, 109, 136	12/20/2007	JM
709	219	12/20/2007	JM

SEARCH NOTES		
Search Notes	Date	Examiner
Spoke to Ryan Yang	12/20/2007	JM
EAST search	12/20/2007	JM
http://en.wikipedia.org/wiki/Main_Page	12/20/2007	JM
http://www.ipdl.inpit.go.jp/homepg_e.ipdl	12/20/2007	JM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner